



December 2014

## FCH190N65F

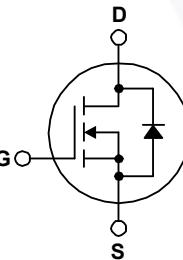
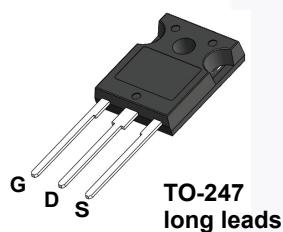
### N-Channel SuperFET® II FRFET® MOSFET 650 V, 20.6 A, 190 mΩ

#### Features

- 700 V @  $T_J = 150^\circ\text{C}$
- Typ.  $R_{DS(on)} = 168 \text{ m}\Omega$
- Ultra Low Gate Charge (Typ.  $Q_g = 60 \text{ nC}$ )
- Low Effective Output Capacitance (Typ.  $C_{oss(\text{eff.})} = 304 \text{ pF}$ )
- 100% Avalanche Tested
- RoHS Compliant

#### Applications

- LCD / LED / PDP TV
- Solar Inverter
- Telecom / Server Power Supplies
- AC - DC Power Supply



#### Absolute Maximum Ratings $T_C = 25^\circ\text{C}$ unless otherwise noted.

Symbol	Parameter		FCH190N65F_F155	Unit
$V_{DSS}$	Drain to Source Voltage		650	V
$V_{GSS}$	Gate to Source Voltage	- DC	$\pm 20$	V
		- AC ( $f > 1 \text{ Hz}$ )	$\pm 30$	
$I_D$	Drain Current	- Continuous ( $T_C = 25^\circ\text{C}$ )	20.6	A
		- Continuous ( $T_C = 100^\circ\text{C}$ )	13.1	
$I_{DM}$	Drain Current	- Pulsed	(Note 1)	A
$E_{AS}$	Single Pulsed Avalanche Energy		400	mJ
$I_{AR}$	Avalanche Current		4.0	A
$E_{AR}$	Repetitive Avalanche Energy		2.1	mJ
$dv/dt$	MOSFET $dv/dt$		100	V/ns
	Peak Diode Recovery $dv/dt$	(Note 3)	50	
$P_D$	Power Dissipation	( $T_C = 25^\circ\text{C}$ )	208	W
		- Derate Above $25^\circ\text{C}$	1.67	$W/\text{ }^\circ\text{C}$
$T_J, T_{STG}$	Operating and Storage Temperature Range		-55 to +150	$^\circ\text{C}$
$T_L$	Maximum Lead Temperature for Soldering, 1/8" from Case for 5 Seconds		300	$^\circ\text{C}$

#### Thermal Characteristics

Symbol	Parameter	FCH190N65F_F155	Unit
$R_{\theta JC}$	Thermal Resistance, Junction to Case, Max.	0.6	$^\circ\text{C}/\text{W}$
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient, Max.	40	

## Package Marking and Ordering Information

Part Number	Top Mark	Package	Packing Method	Reel Size	Tape Width	Quantity
FCH190N65F_F155	FCH190N65F	TO-247 G03	Tube	N/A	N/A	30 units

**Electrical Characteristics**  $T_C = 25^\circ\text{C}$  unless otherwise noted.

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
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### Off Characteristics

BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	$V_{GS} = 0 \text{ V}$ , $I_D = 10 \text{ mA}$ , $T_J = 25^\circ\text{C}$	650	-	-	V
		$V_{GS} = 0 \text{ V}$ , $I_D = 10 \text{ mA}$ , $T_J = 150^\circ\text{C}$	700	-	-	
$\Delta BV_{DSS}$ / $\Delta T_J$	Breakdown Voltage Temperature Coefficient	$I_D = 10 \text{ mA}$ , Referenced to $25^\circ\text{C}$	-	0.72	-	$\text{V}/^\circ\text{C}$
		$V_{DS} = 650 \text{ V}$ , $V_{GS} = 0 \text{ V}$	-	-	10	
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS} = 520 \text{ V}$ , $V_{GS} = 0 \text{ V}$ , $T_C = 125^\circ\text{C}$	-	60	-	$\mu\text{A}$
$I_{GSS}$	Gate to Body Leakage Current	$V_{GS} = \pm 20 \text{ V}$ , $V_{DS} = 0 \text{ V}$	-	-	$\pm 100$	nA

### On Characteristics

$V_{GS(\text{th})}$	Gate Threshold Voltage	$V_{GS} = V_{DS}$ , $I_D = 2 \text{ mA}$	3	-	5	V
$R_{DS(\text{on})}$	Static Drain to Source On Resistance	$V_{GS} = 10 \text{ V}$ , $I_D = 10 \text{ A}$	-	168	190	$\text{m}\Omega$
$g_{FS}$	Forward Transconductance	$V_{DS} = 20 \text{ V}$ , $I_D = 10 \text{ A}$	-	18	-	S

### Dynamic Characteristics

$C_{iss}$	Input Capacitance	$V_{DS} = 100 \text{ V}$ , $V_{GS} = 0 \text{ V}$ , $f = 1 \text{ MHz}$	-	2425	3225	pF
$C_{oss}$	Output Capacitance		-	78	104	pF
$C_{rss}$	Reverse Transfer Capacitance		-	0.68	-	pF
$C_{oss}$	Output Capacitance	$V_{DS} = 380 \text{ V}$ , $V_{GS} = 0 \text{ V}$ , $f = 1 \text{ MHz}$	-	44	-	pF
$C_{oss(\text{eff.})}$	Effective Output Capacitance	$V_{DS} = 0 \text{ V}$ to $400 \text{ V}$ , $V_{GS} = 0 \text{ V}$	-	304	-	pF
$Q_{g(\text{tot})}$	Total Gate Charge at 10V	$V_{DS} = 380 \text{ V}$ , $I_D = 10 \text{ A}$ , $V_{GS} = 10 \text{ V}$	-	60	78	nC
$Q_{gs}$	Gate to Source Gate Charge		-	12	-	nC
$Q_{gd}$	Gate to Drain "Miller" Charge		(Note 4)	25	-	nC
ESR	Equivalent Series Resistance	$f = 1 \text{ MHz}$	-	0.6	-	$\Omega$

### Switching Characteristics

$t_{d(\text{on})}$	Turn-On Delay Time	$V_{DD} = 380 \text{ V}$ , $I_D = 10 \text{ A}$ , $V_{GS} = 10 \text{ V}$ , $R_g = 4.7 \Omega$	-	25	60	ns
$t_r$	Turn-On Rise Time		-	11	32	ns
$t_{d(\text{off})}$	Turn-Off Delay Time		-	62	134	ns
$t_f$	Turn-Off Fall Time		(Note 4)	4.2	18	ns

### Drain-Source Diode Characteristics

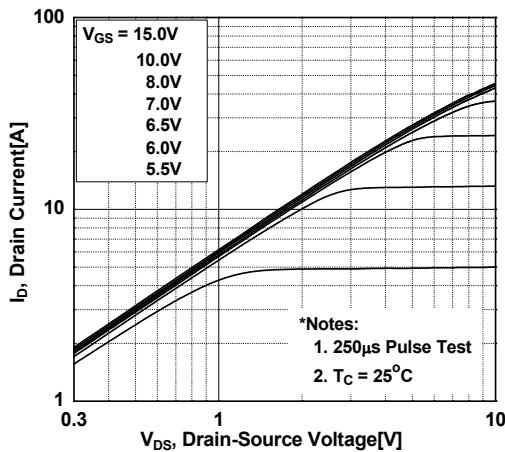
$I_S$	Maximum Continuous Drain to Source Diode Forward Current	-	-	20.6	A
$I_{SM}$	Maximum Pulsed Drain to Source Diode Forward Current	-	-	61.8	A
$V_{SD}$	Drain to Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}$ , $I_{SD} = 10 \text{ A}$	-	-	1.2
$t_{rr}$	Reverse Recovery Time	$V_{GS} = 0 \text{ V}$ , $I_{SD} = 10 \text{ A}$ , $dI_F/dt = 100 \text{ A}/\mu\text{s}$	-	105	-
$Q_{rr}$	Reverse Recovery Charge		-	515	-

#### Notes:

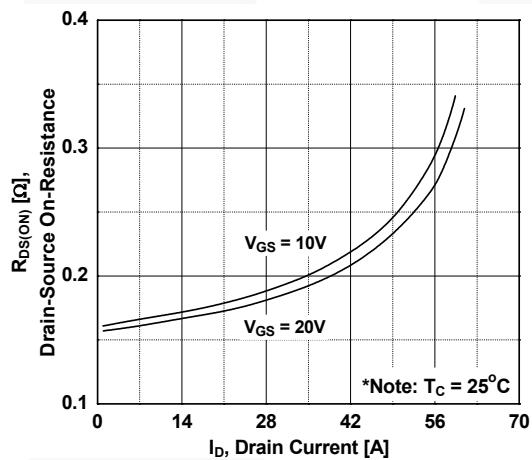
1. Repetitive rating: pulse width limited by maximum junction temperature.
2.  $I_{AS} = 4 \text{ A}$ ,  $R_G = 25 \Omega$ , starting  $T_J = 25^\circ\text{C}$ .
3.  $I_{SD} \leq 10 \text{ A}$ ,  $dI/dt \leq 200 \text{ A}/\mu\text{s}$ ,  $V_{DD} \leq 380 \text{ V}$ , starting  $T_J = 25^\circ\text{C}$ .
4. Essentially independent of operating temperature typical characteristics.

## Typical Performance Characteristics

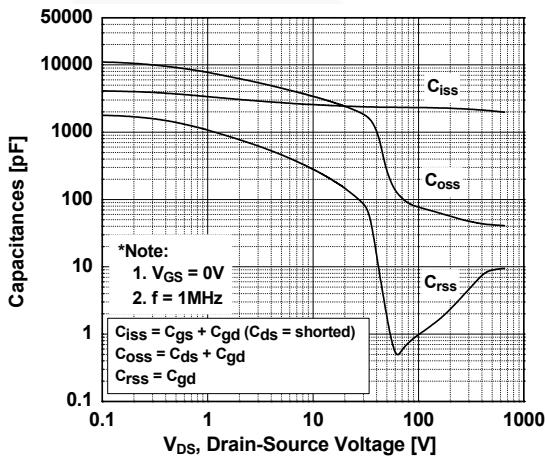
**Figure 1. On-Region Characteristics**



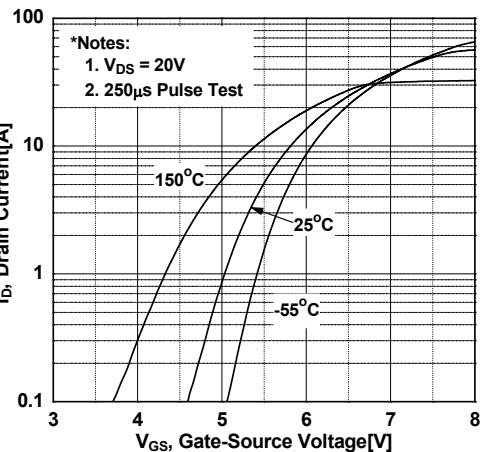
**Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage**



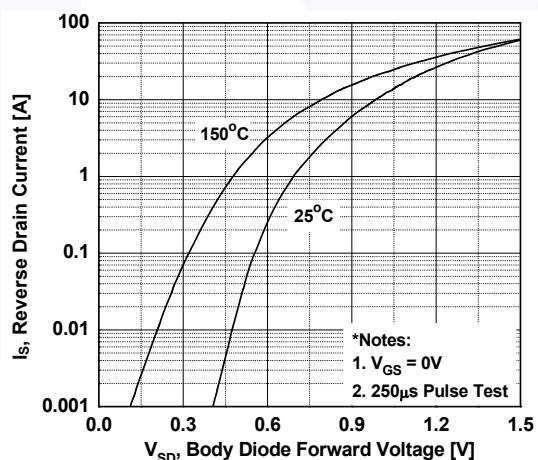
**Figure 5. Capacitance Characteristics**



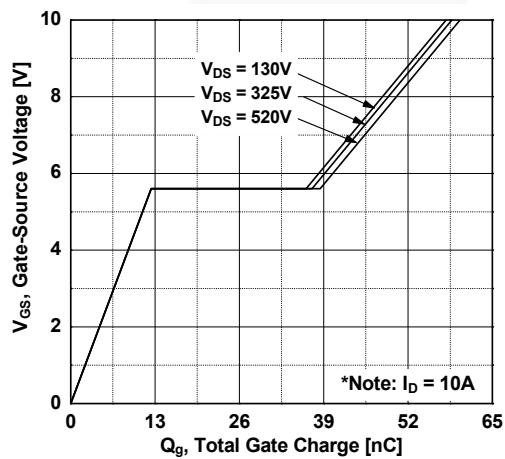
**Figure 2. Transfer Characteristics**



**Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature**

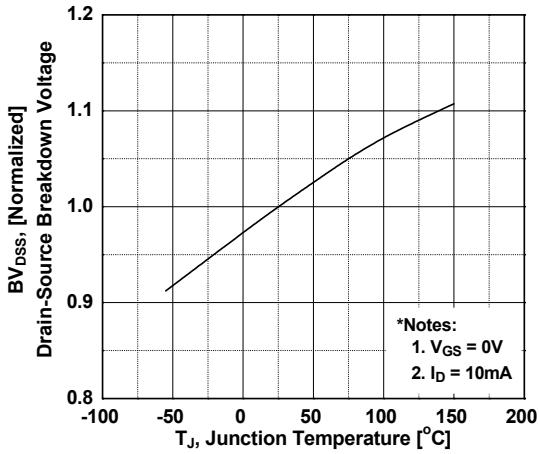


**Figure 6. Gate Charge Characteristics**

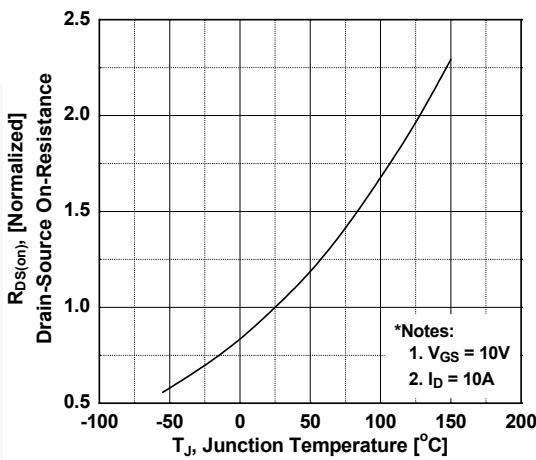


## Typical Performance Characteristics (Continued)

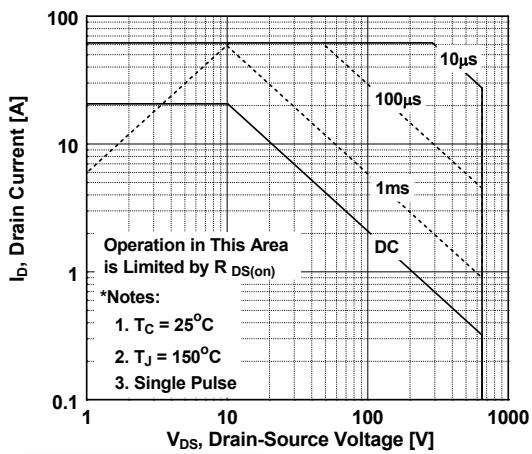
**Figure 7. Breakdown Voltage Variation vs. Temperature**



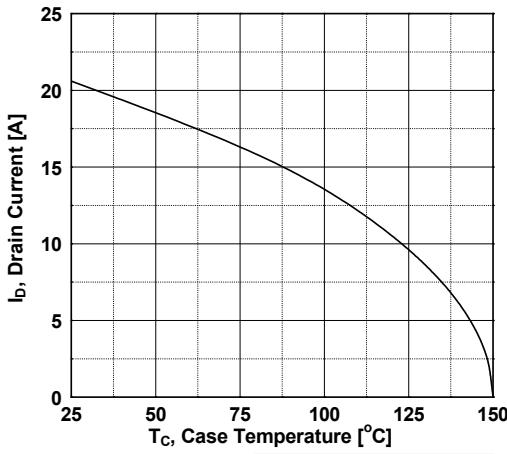
**Figure 8. On-Resistance Variation vs. Temperature**



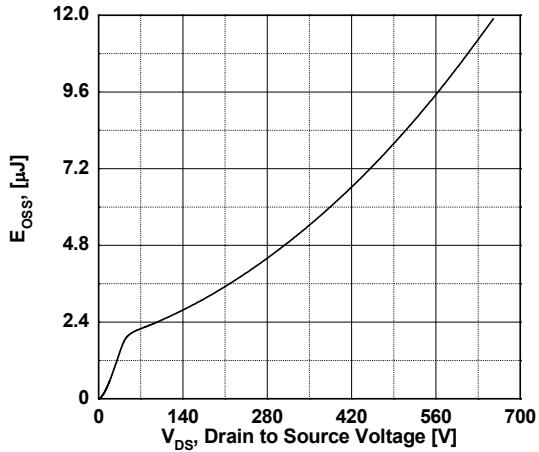
**Figure 9. Maximum Safe Operating Area**



**Figure 10. Maximum Drain Current vs. Case Temperature**

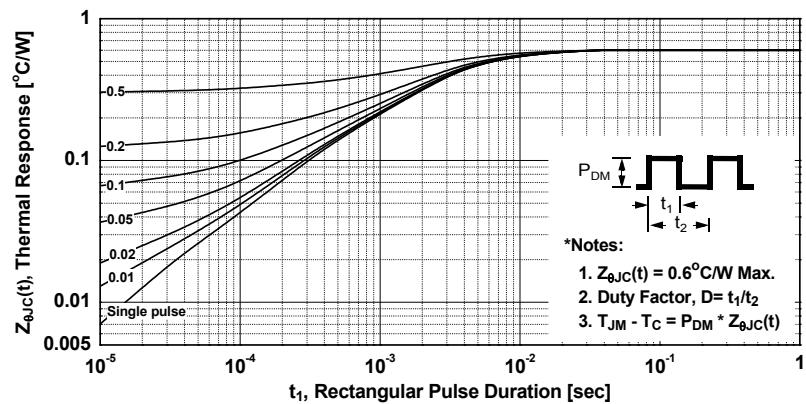


**Figure 11. Eoss vs. Drain to Source Voltage**



## Typical Performance Characteristics (Continued)

Figure 12. Transient Thermal Response Curve



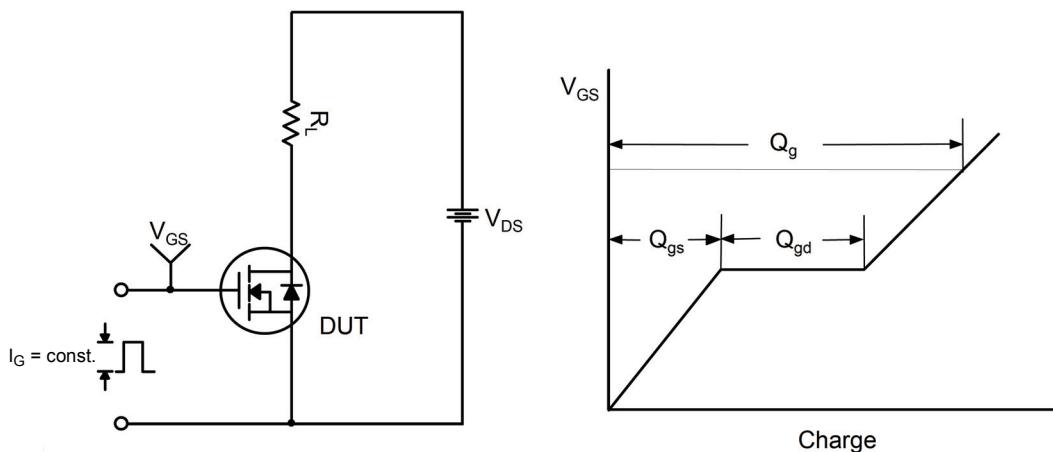


Figure 13. Gate Charge Test Circuit & Waveform

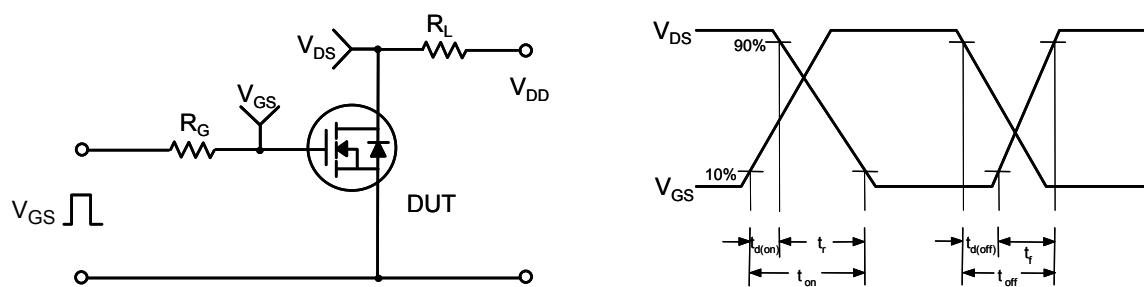


Figure 14. Resistive Switching Test Circuit & Waveforms

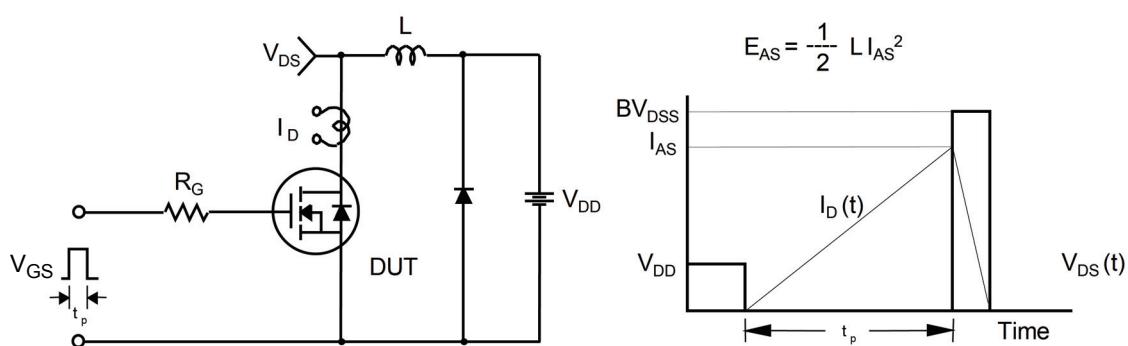


Figure 15. Unclamped Inductive Switching Test Circuit & Waveforms

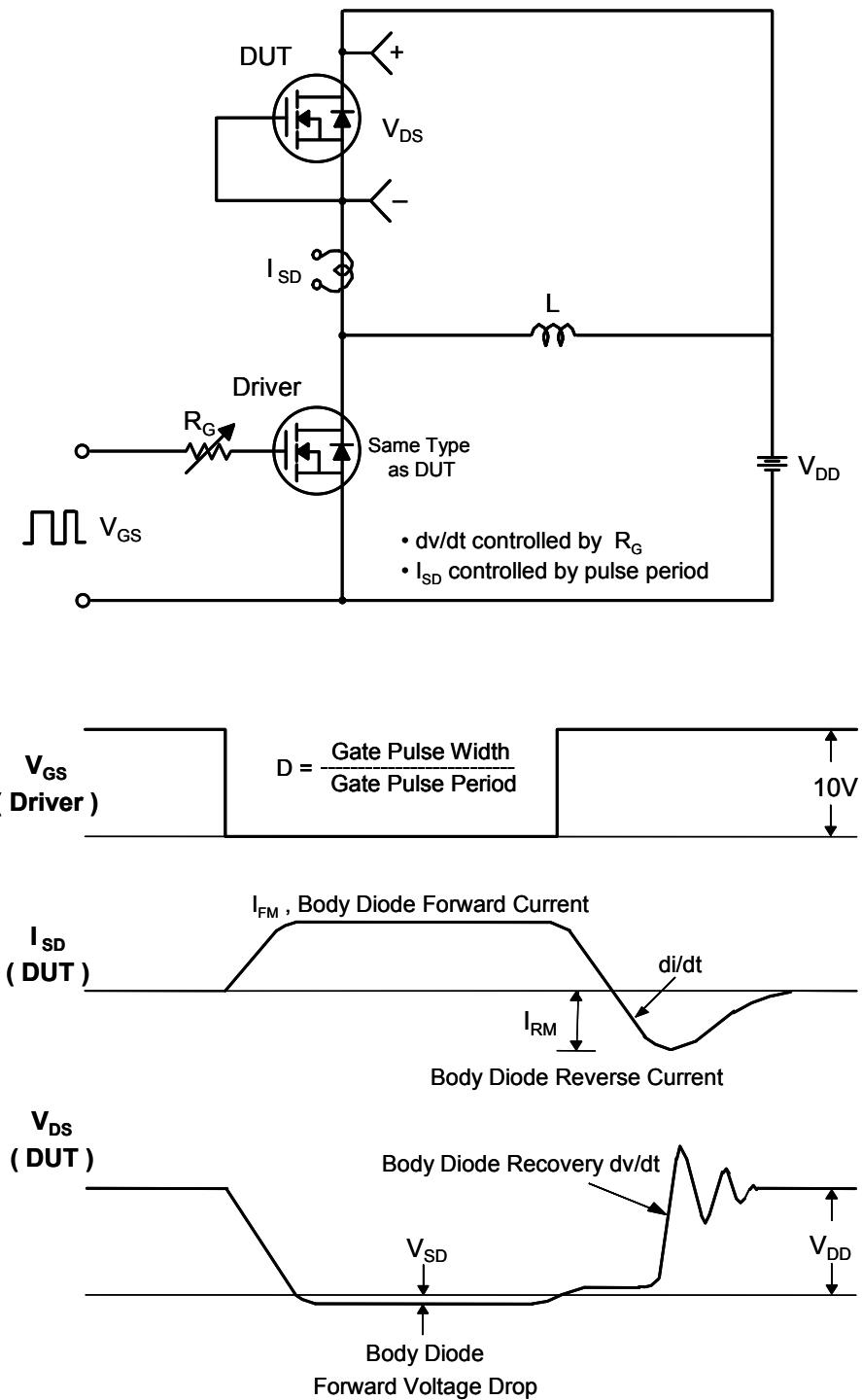
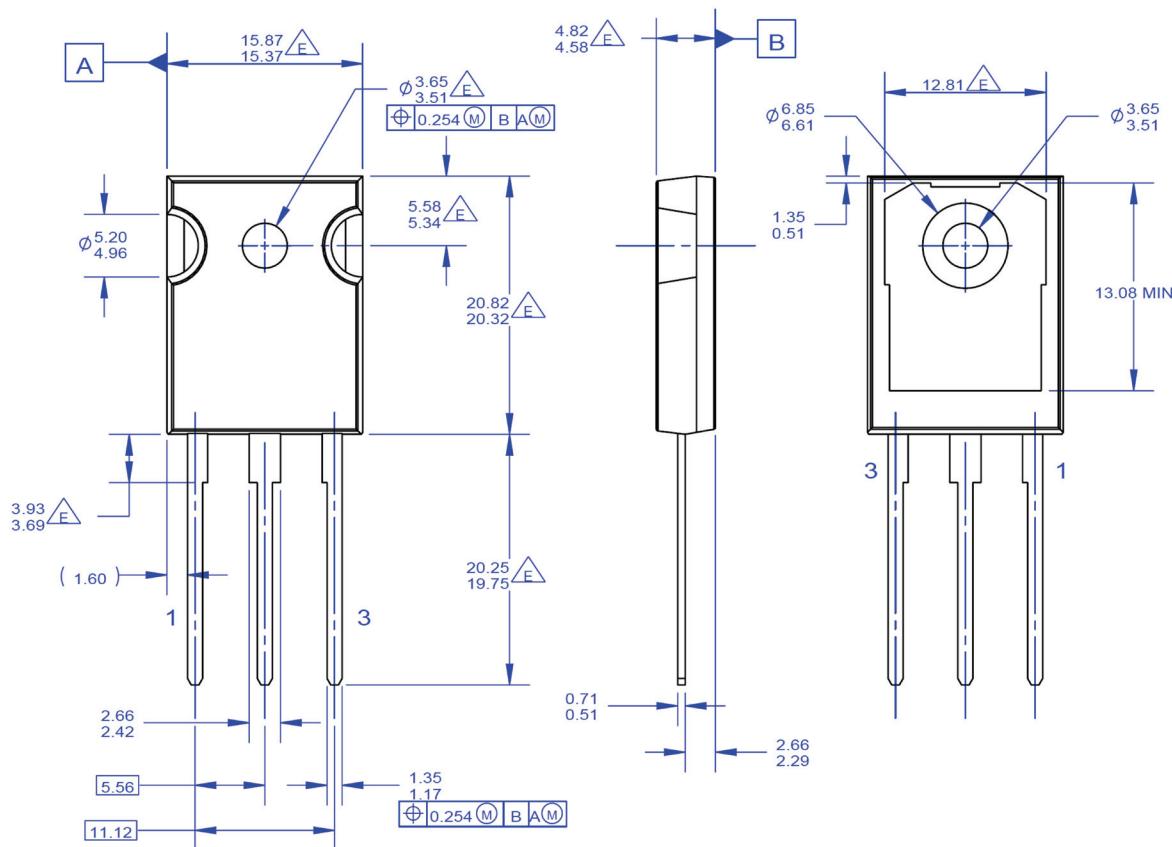


Figure 16. Peak Diode Recovery  $dv/dt$  Test Circuit & Waveforms

### **Mechanical Dimensions**



**NOTES: UNLESS OTHERWISE SPECIFIED.**

- A. PACKAGE REFERENCE: JEDEC TO-247,  
ISSUE E, VARIATION AB, DATED JUNE, 2004.
  - B. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD  
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  - C. ALL DIMENSIONS ARE IN MILLIMETERS.
  - D. DRAWING CONFORMS TO ASME Y14.5 - 1994

 DOES NOT COMPLY JEDEC STANDARD VALUE  
F. DRAWING FILENAME: MKT-TO247G03\_REV01

**Figure 17. TO-247, Molded, 3-Lead, Jedec AB Long Leads**

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